Industrial microSD 3.0 Read-Only Mode (ROM) MLC

Version 1.1

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1. GENERAL DESCRIPTION

1.1 Introduction

The Read-Only Mode is highly effective in a memory device to ensure data security. Read-Only mode provides a tamper-proof data storage solution by making it unalterable and the crucial files remain safe.

FLEXXON Read Only Mode (ROM) microSD Card provides security function to prevent the stored data from being stolen, tampered or modified by others. Once you activate the Read-Only mode into the memory card, all the stored data enables access for reading only. None can change, delete, or overwrite anything from the stored data. So, you can preserve the authenticity of the essential files into the memory card and prohibit it from the risk of alteration. Write access could only be enabled by authorized user with specific tool and correct password.

FLEXXON ROM microSD Card plays an important role in various applications where ensuring data authenticity is extremely important. For example, in medical and healthcare facilities, financial institutes, business organizations, the cybersecurity industry, etc. will be beneficial by utilizing Read-Only Mode memory card.

The read only mode is an additional feature, which will not affect the standard product specification.

1.2 Product Overview

◆ **Flash** MLC	◆ **Support SD System Specification 3.0**
◆ **Capacity** 4GB to 128GB	◆ **Support SD SPI Mode**
◆ **Support Data Encryption**	◆ **Support Auto Read Refreshment**
◆ **Read disturbance management**	◆ **Adaptive wear leveling**
◆ **Support management of sudden power fails**	◆ **SMART function support**
◆ **Temperature Range** Operation (Gold): -25°C ~ 85°C Operation (Diamond): -40°C ~ 85°C ◆ Storage: -40°C ~ 85°C	

1.3 Workflow

FLEXXON ROM microSD Card is a normal mode by default. User could set the password to enable read only mode by software tool.

Note: User is required to eject and re-insert the after set the password.

User could enable write access by the legal host with security tool and enter correct password. When user power off the host or reinsert the card, the card will return to read only mode.
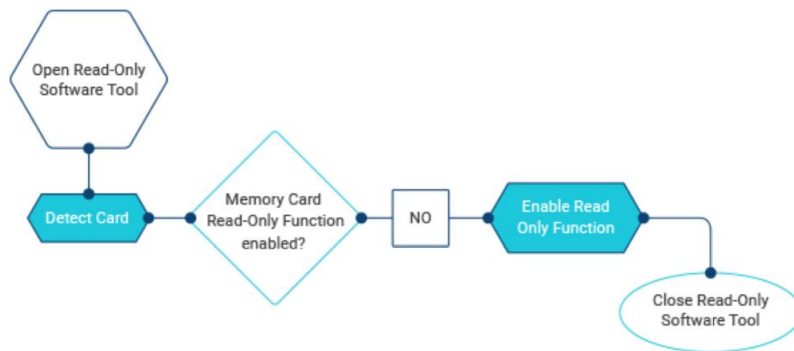
Enable ROM Function by Software Tool and Password

Figure 1-1: Enable ROM Function by software tool and password

Enable Write Access by software tool and password
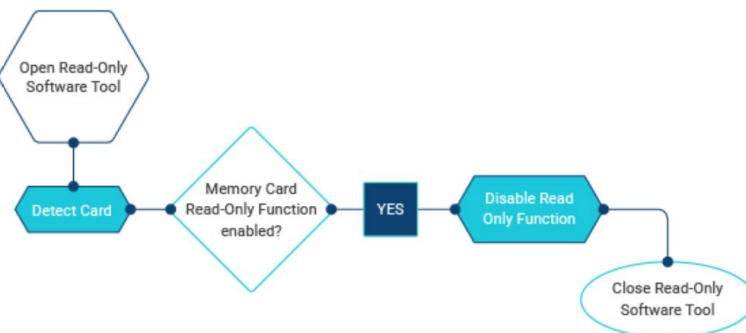
Figure 1-2: Enable Write Access by software tool and password

2. PRODUCT SPECIFICATIONS

2.1 Performance

Capacity	Sequential	
	Read (MB/s)	Write (MB/s)
4GB	90	25
8GB	90	25
16GB	90	50
32GB	90	75
64GB	90	80
128GB	90	80

Table 2-1 Performance of ROM microSD

NOTES:

1. The performance is obtained from TestMetrix
2. Performance may vary from flash configuration and platform.

2.2 Power

Capacity	Read (mA)	Write (mA)	Standby (uA)
4GB	180	90	220
8GB	180	90	220
16GB	190	120	250
32GB	190	140	280
64GB	190	170	320
128GB	195	170	500

Table 2-2 Typical Power Consumption of ROM microSD

2.3 MTBF

MTBF, an acronym for Mean Time Between Failures, is a measure of a device's reliability. Its value represents the average time between a repair and the next failure. The higher the MTBF value, the higher the reliability of the device. The predicted result of ROM microSD Card is more than 3,000,000 hours.

3. ENVIRONMENTAL SPECIFICATIONS

Test Items	Test Conditions
Storage Temperature	-40°C ~ 85°C
Operating Temperature	Gold: -25°C ~ 85°C Diamond: -40°C ~ 85°C
Storage Humidity	40°C, 93% RH
Operating Humidity	25°C, 95% RH
Shock	1500G, Half Sin Pulse Duration 0.5ms
Vibration	80Hz ~ 2000Hz/20G, 20Hz ~ 80Hz/1.52mm, 3 axis/30min
Drop	150cm free fall, 6 face of each unit
Bending	≥ 10N, Hold 1 min/5 times
Torque	0.1N-m or +/-2.5 deg, Hold 30 seconds/5 times
ESD	Contact: +/- 4KV each item 25 times Air: +/- 8KV 10 times

Table 3-1 Environmental Specification

4.1 DC Characteristics

4.1.1 Bus Operation Conditions for 3.3V Signaling

Parameter	Symbol	Min.	Max	Unit	Condition
Supply Voltage	V_{DD}	2.7	3.6	V	
Output High Voltage	V_{OH}	$0.75*V_{DD}$		V	I_{OH}=-2mA V_{DD} Min
Output Low Voltage	V_{OL}		$0.125*V_{DD}$	V	I_{OL}=2mA V_{DD} Min
Input High Voltage	V_{IH}	$0.625*V_{DD}$	V_{DD}+0.3	V	
Input Low Voltage	V_{IL}	V_{SS}-0.3	$0.25*V_{DD}$	V	
Power Up Time			250	ms	From 0V to V_{DD} min

Table 4-1 Threshold Level for High Voltage Range

Parameter	Symbol	Min.	Max	Unit	Condition
Supply Voltage	V_{DD}	2.7	3.6	V	
Regulator Voltage	V_{DDIO}	1.7	1.95	V	Generated by V_{DD}
Output High Voltage	V_{OH}	1.4	-	V	I_{OH}=-2mA
Output Low Voltage	V_{OL}	-	0.45	V	I_{OL}=2mA
Input High Voltage	V_{IH}	1.27	2.00	V	
Input Low Voltage	V_{IL}	V_{SS}-0.3	0.58	V	

Table 4-2 Threshold Level for 1.8V Signaling

Parameter	Symbol	Min	Max.	Unit	Remarks
Input Leakage Current		-2	2	uA	DAT3 pull-up is disconnected.

Table 4-3 Input Leakage Current for 1.8V Signaling

Parameter	Symbol	Min	Max.	Unit	Remarks
Peak voltage on all lines		-0.3	V_{DD}+0.3	V	
All Inputs					
Input Leakage Current		-10	10	uA	
All Outputs					
Output Leakage Current		-10	10	uA	

Table 4-4 Peak Voltage and Leakage Current

4.1.2 Bus Signal Line Load

Bus Operation Conditions – Signal Line's Load

Total Bus Capacitance = $C_{HOST} + C_{BUS} + N\ C_{CARD}$

Parameter	symbol	Min	Max	Unit	Remark
Pull-up resistance	R_{CMD} R_{DAT}	10	100	kΩ	to prevent bus floating
Total bus capacitance for each signal line	C_L		40	pF	1 card $C_{HOST}+C_{BUS}$ shall not exceed 30 pF
Card Capacitance for each signal pin	C_{CARD}		10[1]	pF	
Maximum signal line inductance			16	nH	
Pull-up resistance inside card (pin1)	R_{DAT3}	10	90	kΩ	May be used for card detection
Capacity Connected to Power Line	C_C		5	uF	To prevent inrush current

Table 4-5 Peak Voltage and Leakage Current

4.2 AC Characteristic
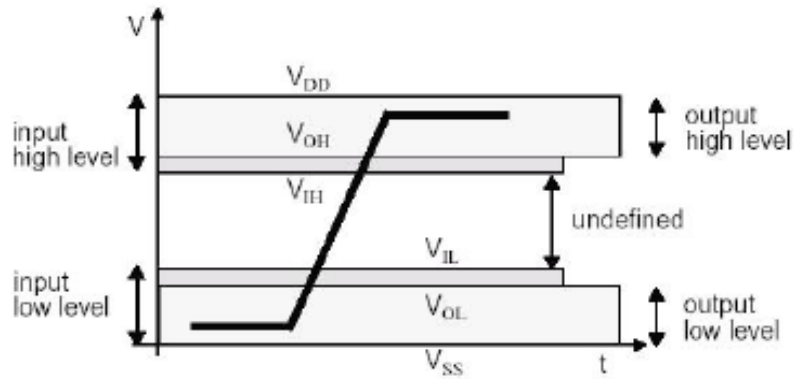
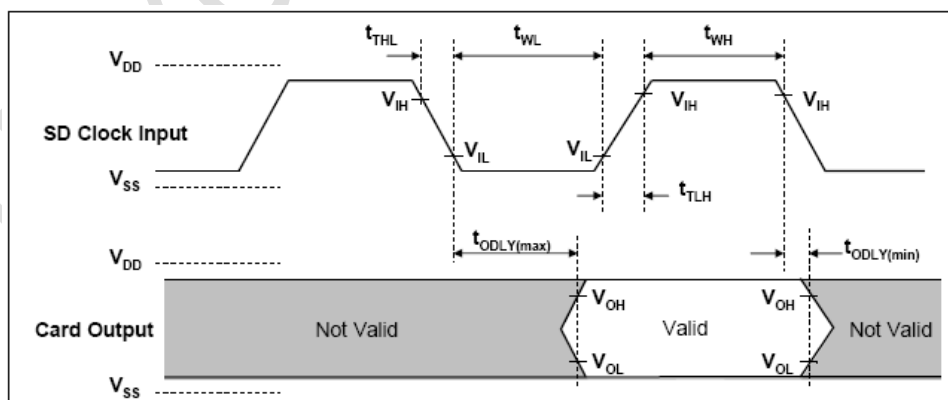## 4.2.1 microSD Interface timing (Default)
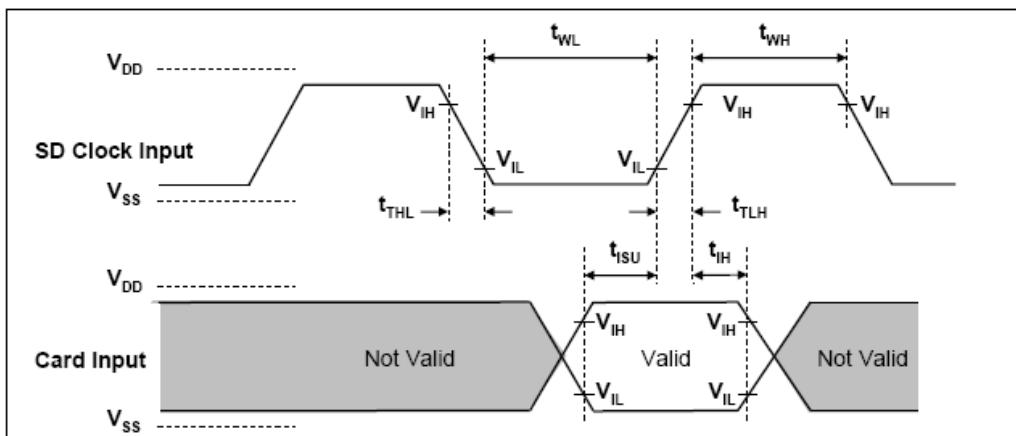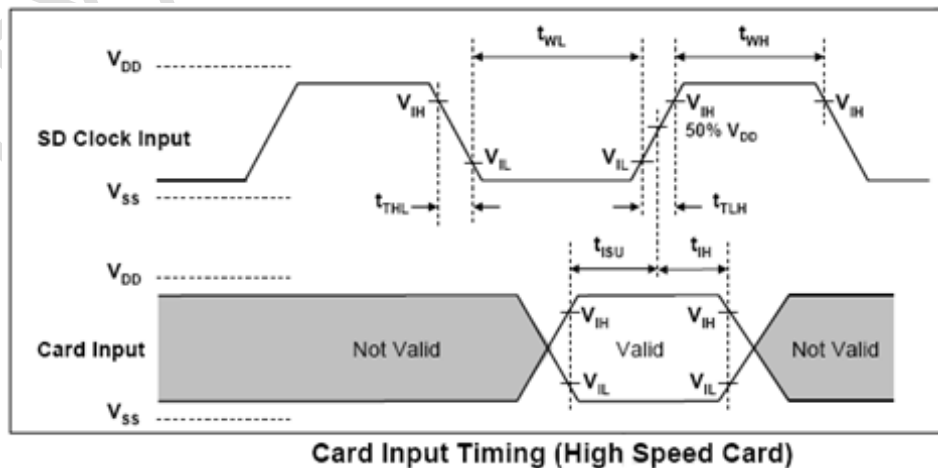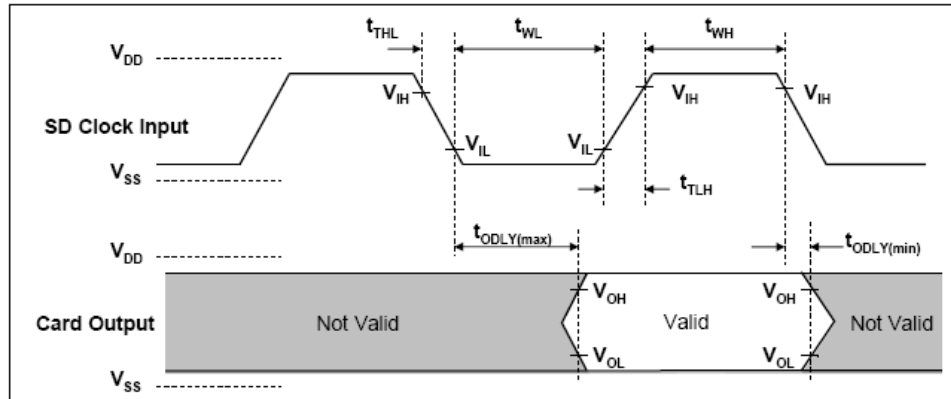

Card Input Timing (Default Speed Card)

Card Output Timing (Default Speed Mode)

Parameter	Symbol	Min	Max	Unit	Remark
Clock CLK (All values are referred to min(V_{IH}) and max(V_{IL})					
Clock frequency Data Transfer Mode	f_{PP}	0	25	MHz	$C_{card} \leq 10$ pF (1 card)
Clock frequency Identification Mode	f_{OD}	$0_{(1)}/100$	400	KHz	$C_{card} \leq 10$ pF (1 card)
Clock low time	t_{WL}	10		ns	$C_{card} \leq 10$ pF (1 card)
Clock high time	t_{WH}	10		ns	$C_{card} \leq 10$ pF (1 card)
Clock rise time	t_{TLH}		10	ns	$C_{card} \leq 10$ pF (1 card)
Clock fall time	t_{THL}		10	ns	$C_{card} \leq 10$ pF (1 card)
Inputs CMD, DAT (referenced to CLK)					
Input set-up time	t_{ISU}	5		ns	$C_{card} \leq 10$ pF (1 card)
Input hold time	t_{IH}	5		ns	$C_{card} \leq 10$ pF (1 card)
Outputs CMD, DAT (referenced to CLK)					
Output Delay time during Data Transfer Mode	t_{ODLY}	0	14	ns	$C_L \leq 40$ pF (1 card)
Output Delay time during Identification Mode	t_{ODLY}	0	50	ns	$C_L \leq 40$ pF (1 card)

(1) 0Hz means to stop the clock. The given minimum frequency range is for cases where continues clock is required.

4.2.2 microSD Interface Timing (High-Speed Mode)

Card Input Timing (High Speed Card)

Card Output Timing (Default Speed Mode)

Parameter	Symbol	Min	Max	Unit	Remark
Clock CLK (All values are referred to min(V_{IH}) and max(V_{IL})					
Clock frequency Data Transfer Mode	f_{PP}	0	50	MHz	$C_{card} \leq 10$ pF (1 card)
Clock low time	t_{WL}	7		ns	$C_{card} \leq 10$ pF (1 card)
Clock high time	t_{WH}	7		ns	$C_{card} \leq 10$ pF (1 card)
Clock rise time	t_{TLH}		3	ns	$C_{card} \leq 10$ pF (1 card)
Clock fall time	t_{THL}		3	ns	$C_{card} \leq 10$ pF (1 card)
Inputs CMD, DAT (referenced to CLK)					
Input set-up time	t_{ISU}	6		ns	$C_{card} \leq 10$ pF (1 card)
Input hold time	t_{IH}	2		ns	$C_{card} \leq 10$ pF (1 card)
Outputs CMD, DAT (referenced to CLK)					
Output Delay time during Data Transfer Mode	t_{ODLY}		14	ns	$C_L \leq 40$ pF (1 card)
Output Hold time	T_{OH}	2.5		ns	$C_L \leq 15$ pF (1 card)
Total System capacitance of each line[1]	C_L		40	pF	CL ≤ 15 pF (1 card)

(1) In order to satisfy severe timing, the host shall drive only one card.

## 4.2.3 microSD Interface timing (SDR12, SDR25, SDR50 and SDR104 Modes)

Input:
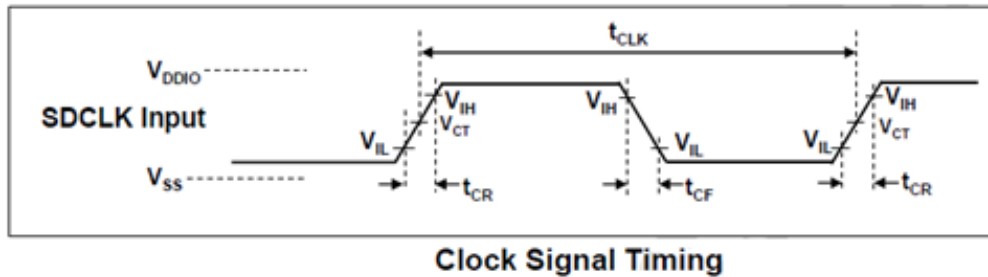
Clock Signal Timing

Symbol	Min	Max	Unit	Remark
t_{CLK}	4.80	-	ns	208MHz (Max.), Between rising edge, V_{CT}= 0.975V
t_{CR}, t_{CF}	-	0.2* t_{CLK}	ns	t_{CR}, t_{CF} < 0.96ns (max.) at 208MHz, C_{CARD}=10pF t_{CR}, t_{CF} < 2.00ns (max.) at 100MHz, C_{CARD}=10pF The absolute maximum value of t_{CR}, t_{CF} is 10ns regardless of clock frequency
Clock Duty	30	70	%	

Clock Signal Timing

SDR50 and SDR104 Input Timing:
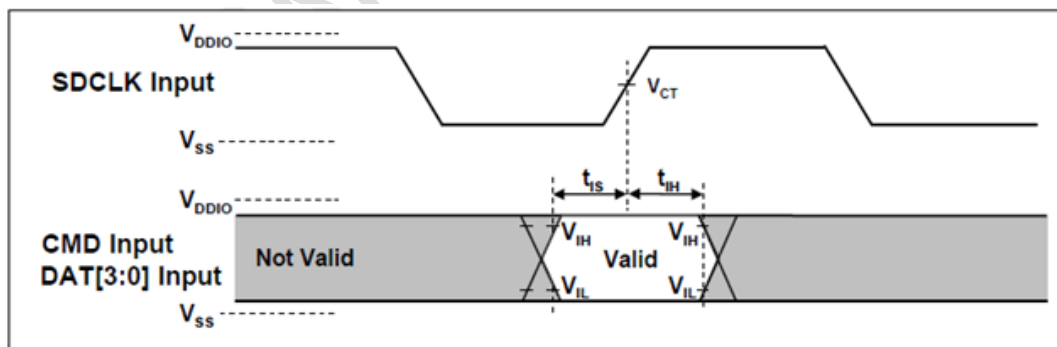
Card Input Timing

Symbol	Min	Max	Unit	SDR104 Mode
t_{IS}	1.40	-	ns	C_{CARD} =10pF, V_{CT}= 0.975V
t_{IH}	0.8	-	ns	C_{CARD} = 5pF, V_{CT}= 0.975V
Symbol	Min	Max	Unit	SDR50 Mode
t_{IS}	3.00	-	ns	C_{CARD} =10pF, V_{CT}= 0.975V
t_{IH}	0.8	-	ns	C_{CARD} = 5pF, V_{CT}= 0.975V

Output (SDR12, SDR25, SDR50):
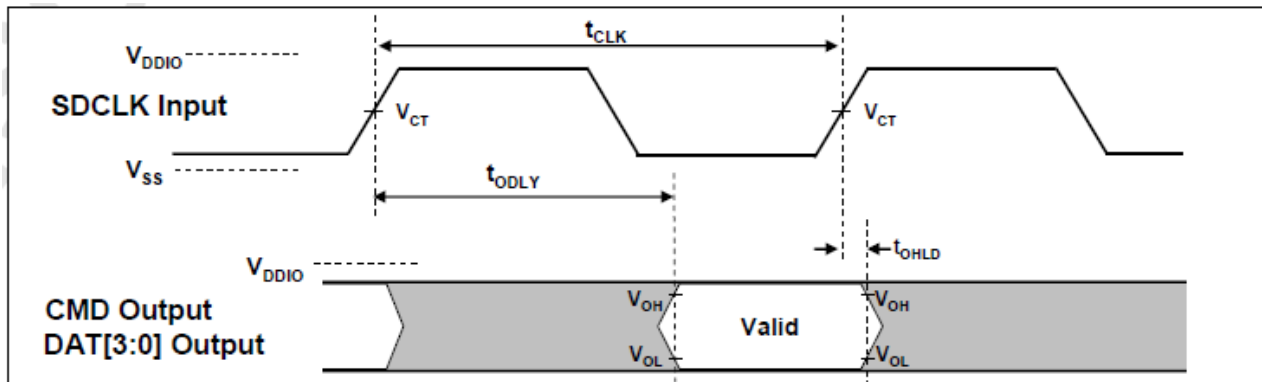
Output Timing of Fixed Data Window

Symbol	Min	Max	Unit	Remark
t_{ODLY}	-	7.5	ns	t_{CLK}>=10.0ns, C_L=30pF, using driver Type B, for SDR50
t_{ODLY}	-	14	ns	t_{CLK}>=20.0ns, C_L=40pF, using driver Type B, for SDR25 and SDR12,
T_{OH}	1.5	-	ns	Hold time at the t_{ODLY} (min.), C_L=15pF

Output (SDR104 Mode):
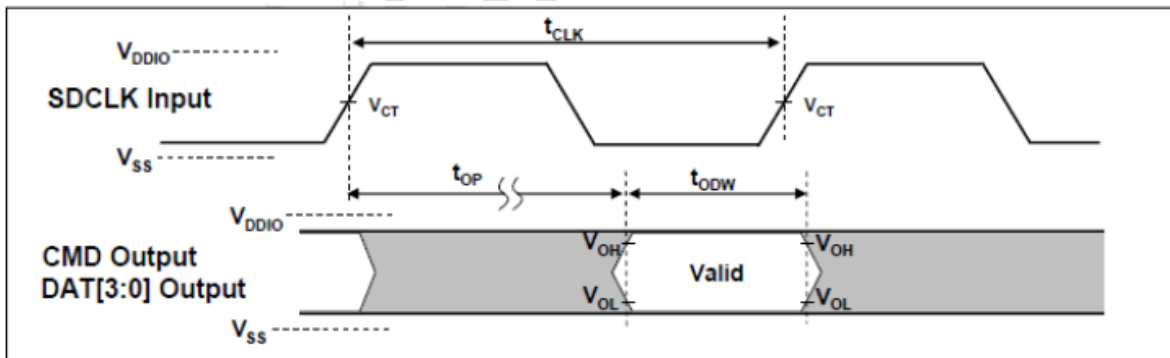
Symbol	Min	Max	Unit	Remark
t_{OP}	0	2	UI	Card Output Phase
$\triangle t_{OP}$	-350	+1550	ps	Delay variable due to temperature change after tuning
t_{ODW}	0.60	-	UI	t_{ODW} = 2.88ns at 208MHz

4.2.4 microSD Interface timing (DDR50 Modes)
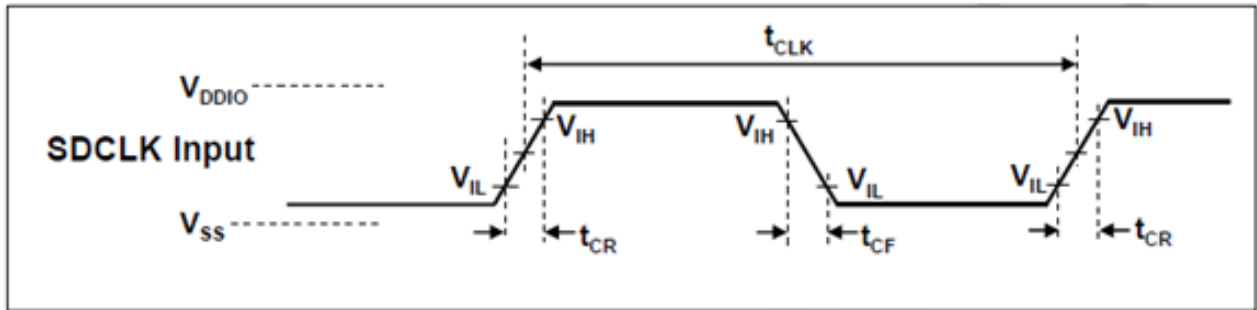
Clock Signal Timing

Symbol	Min	Max	Unit	Remark
t_{CLK}	20	-	ns	50MHz (Max.), Between rising edge
t_{CR}, t_{CF}	-	$0.2* t_{CLK}$	ns	t_{CR}, t_{CF} < 4.00ns (max.) at 50MHz, C_{CARD}=10pF
Clock Duty	45	55	%	
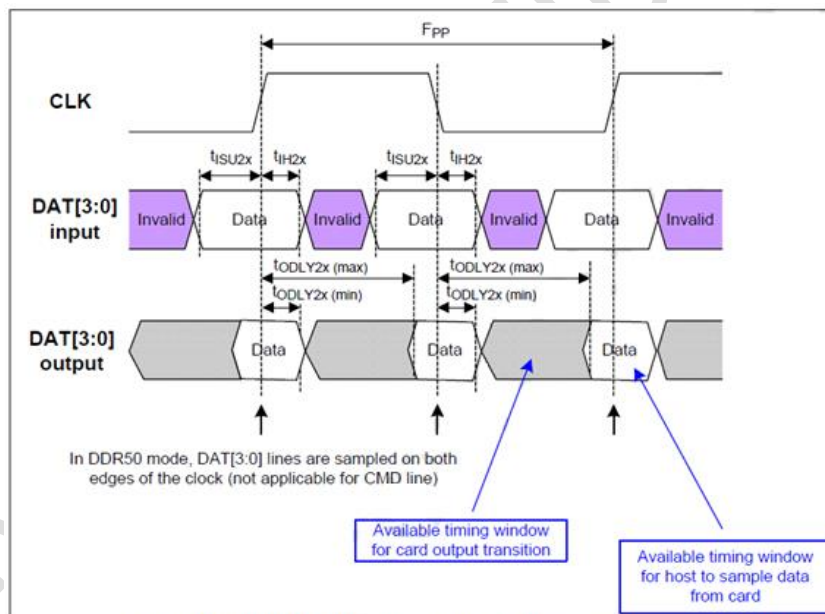
Timing Diagram DAT Inputs/Outputs Referenced to CLK in DDR50 Mode

| Parameter	Symbol	Min	Max	Unit	Remark
Input CMD (referenced to CLK rising edge)					
Input set-up time	t_{ISU}	3	-	ns	$C_{card} \leq 10$ pF (1 card)
Input hold time	t_{IH}	0.8	-	ns	$C_{card} \leq 10$ pF (1 card)
Output CMD (referenced to CLK rising edge)					
Output Delay time during Data Transfer Mode	t_{ODLY}		13.7	ns	$C_L \leq 30$ pF (1 card)
Output Hold time	T_{OH}	1.5	-	ns	$C_L \geq 15$ pF (1 card)
Inputs DAT (referenced to CLK rising and falling edges)					
Input set-up time	t_{ISU2x}	3	-	ns	$C_{card} \leq 10$ pF (1 card)
Input hold time	t_{IH2x}	0.8	-	ns	$C_{card} \leq 10$ pF (1 card)
Outputs DAT (referenced to CLK rising and falling edges)					
Output Delay time during Data Transfer Mode	t_{ODLY2x}	-	7.0	ns	$C_L \leq 25$ pF (1 card)
Output Hold time	T_{OH2x}	1.5	-	ns	$C_L \geq 15$ pF (1 card)

Table 4-6 Bus Timings – Parameters Values (DDR50 Mode)

5. PAD ASSIGNMENT
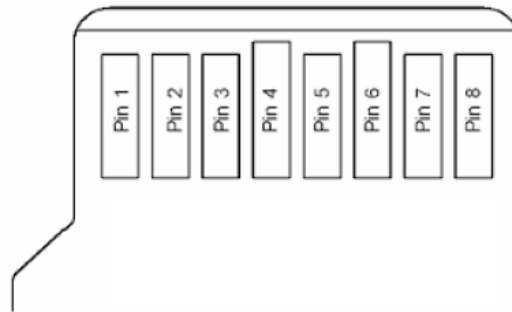
Pin #	SD Mode			SPI Mode		
	Name	**Type [1]**	**Description**	**Name**	**Type**	**Description**
1	DAT2	I/O/PP	Data Line[bit2]	RSV		
2	CD/DAT3 [2]	I/O/PP [3]	Card Detect/ Data Line[bit3]	CS	I [3]	Chip Select (neg true)
3	CMD	PP	Command/Response	DI	I	Data In
4	V_{DD}	S	Supply voltage	V_{DD}	S	Supply voltage
5	CLK	I	Clock	SCLK	I	Clock
6	V_{SS}	S	Supply voltage ground	V_{SS}	S	Supply voltage ground
7	DAT0	I/O/PP	Data Line[bit0]	DO	O/PP	Data Out
8	DAT1	I/O/PP	Data Line[bit1]	RSV		

Table 5-1 microSD Pad Assignment

NOTE:
(1) S: power supply, I: input; O: output using push-pull drivers; PP: I/O using push-pull drivers
(2) The extended DAT lines (DAT1-DAT3) are input on power up. They start to operate as DAT lines after SET_BUS_WIDTH command. The Host shall keep its own DAT1-DAT3 lines in input mode, as well, while they are not used. It is defined so, in order to keep compatibility to MultiMedia Cards.
(3) At power up this line has a 50KOhm pull up enabled in the card. This resistor serves two functions: Card detection and Mode Selection. For Mode Selection, the host can drive the line high or let it be pulled high to select SD mode. If the host wants to select SPI mode it should drive the line low. For Card detection, the host detects that the line is pulled high. This pull-up should be disconnected by the user during regular data transfer period, with SET_CLR_CARD_DETECT (ACMD42) command.

6. REGISTERS

| Name	Width	Description
CID	128bit	Card identification number; card individual number for identification.
RCA	16bit	Relative card address; local system address of a card, dynamically suggested by the card and approved by the host during initialization.
DSR	16bit	Driver Stage Register; to configure the card's output drivers.
CSD	128bit	Card Specific Data; Information about the card operation conditions.
SCR	64bit	SD Configuration Register; Information about the SD Memory Card's Special Features capabilities
OCR	32bit	Operation conditions register.
SSR	512bit	SD Status; Information about the card proprietary features.
OCR	32bit	Card Status; Information about the card status.

Table 6-1 microSD Registers

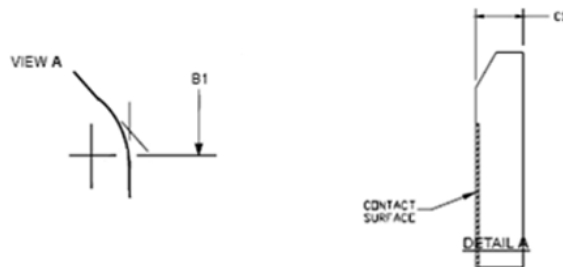# 7. PHYSICAL DIMENSION

Dimension: 15mm (L) x 11mm (W) x 1mm (H)

Top View
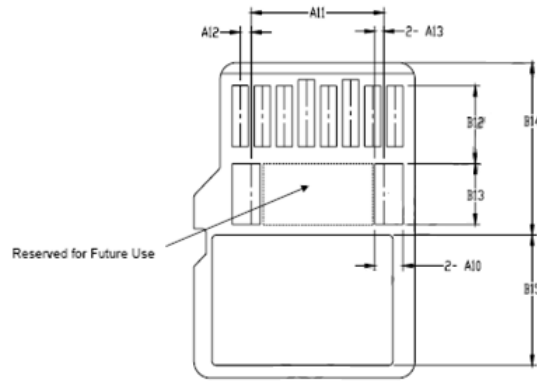
Bottow View
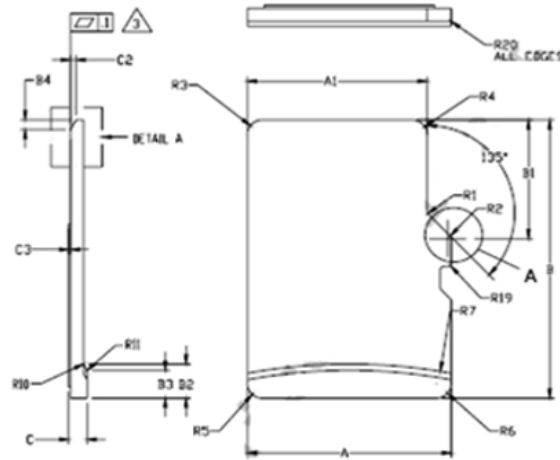
Side View

Common Dimensions				
Symbol	**Min**	**Nom**	**Max**	**Note**
A	10.90	11.00	11.10	
A1	9.60	9.70	9.80	
A2	-	3.85	-	Basic
A3	7.60	7.70	7.80	
A4	-	1.10	-	Basic
A5	0.75	0.80	0.85	
A6	-	-	8.50	
A7	0.90	-	-	
A8	0.60	0.70	0.80	
A9	0.80	-	-	
A10	1.35	1.40	1.45	
A11	6.50	6.60	6.70	
A12	0.50	0.55	0.60	
A13	0.40	0.45	0.50	
B	14.90	15.00	15.10	
B1	6.30	6.40	6.50	
B2	1.64	1.84	2.04	
B3	1.30	1.50	1.70	
B4	0.42	0.52	0.62	
B5	2.80	2.90	3.00	
B6	5.50	-	-	
B7	0.20	0.30	0.40	
B8	1.00	1.10	1.20	
B9	-	-	9.00	
B10	7.60	7.90	8.00	
B11	1.10	1.20	1.30	
B12	3.60	3.70	3.80	
B13	2.80	2.90	3.00	
B14	8.20	-	-	
B15	-	-	6.20	
C	0.90	1.00	1.10	
C1	0.60	0.70	0.80	
C2	0.20	0.30	0.40	
C3	-	-	0.15	
D1	1.00	-	-	
D2	1.00	-	-	
D3	1.00	-	-	
R1	0.20	0.40	0.60	
R2	0.20	0.40	0.60	
R3	0.70	0.80	0.90	
R4	0.70	0.80	0.90	
R5	0.60	0.80	0.90	
R6	0.60	0.80	0.90	
R7	29.50	30.00	30.50	
R10	-	0.20	-	
R11	-	0.20	-	
R17	0.10	0.20	0.30	
R18	0.20	0.40	0.60	
R19	0.05	-	0.20	
R20	0.02	-	0.15	

Notes:
1. Dimensioning and tolerancing per ASME Y14.5M-1994
2. Dimensions are in millimeters.
3. Coplanarity is additive to C1 Max. thickness

8. ORDERING INFORMATION

Capacity	MPN (Diamond Grade)	MPN (Gold Grade)
4GB	FDMM004GME-XR00	FDMM004GMG-XR00
8GB	FDMM008GME-XR00	FDMM008GMG-XR00
16GB	FDMM016GME-XR00	FDMM016GMG-XR00
32GB	FDMM032GME-XR00	FDMM032GMG-XR00
64GB	FDMM064GME-XR00	FDMM064GMG-XR00
128GB	FDMM128GME-XR00	FDMM128GMG-XR00

REVISION HISTORY

Revision	Date	History
1.0	2020/11	First Release
1.1	2021/01	Update Chapter 1 and Ordering Information